

• General Description

The AGM035N10H combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

This device is ideal for load switch and battery protection applications.

Features

- Advance high cell density Trench technology
- Low R_{DS(ON)} to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

Application

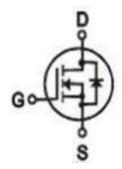
- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

BVDSS	RDSON	ID
100V	3.5mΩ	150A

TO-263 Pin Configuration





Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM035N10H	AGM035N10H	TO-263			800

Table 1. Absolute Maximum Ratings (TA=25℃)

Symbol	Parameter	Value	Unit
VDS	Drain-Source Voltage (VGS=0V)	100	V
VGS	Gate-Source Voltage (VDS=0V)	±20	V
ID	Drain Current-Continuous(Tc=25℃) (Note 1)	150	А
_	Drain Current-Continuous(Tc=100℃)	105	А
IDM (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 2)	600	А
PD	Maximum Power Dissipation(Tc=25℃)	208	w
	Maximum Power Dissipation(Tc=100℃)	83	w
EAS	Avalanche energy (Note 3)	540	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	${\mathbb C}$

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
RθJA	Thermal Resistance Junction-ambient (Steady State) ¹		60	°C/W
RθJC	Thermal Resistance Junction-Case ¹		0.6	°C/W



Table 3. Electrical Characteristics (TA=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off Sta	tes					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250µA	100			V
IDSS	Zero Gate Voltage Drain Current	VDS=100V,VGS=0V			1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=250μA	2.5	3.0	3.5	V
gFS	Forward Transconductance	VDS=5V,ID=7A		130		S
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=75A		3.5	4.1	mΩ
. (20(011)	Drain Cource on State Necistaries	VGS=4.5V, ID=7A				mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance	VDS=50V,		3500		pF
Coss	Output Capacitance	VGS=0V,		1200		pF
Crss	Reverse Transfer Capacitance	F=1MHZ		27		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		0.77		Ω
Switching	Times					
td(on)	Turn-on Delay Time			25		nS
tr	Turn-on Rise Time	VGS=10V,VDS=50V,		33	-	nS
td(off)	Turn-Off Delay Time	ID=75A,RGEN=5Ω		95		nS
tf	Turn-Off Fall Time			75		nS
Qg	Total Gate Charge			67.2	-	nC
Qgs	Gate-Source Charge	VGS=0-10V, VDS=50V, ID=75A		16.9		nC
Qgd	Gate-Drain Charge			16.9		nC
Source-Dr	ain Diode Characteristics	•	1			
ISD	Source-Drain Current(Body Diode)				150	Α
VSD	Forward on Voltage	VGS=0V,IS=75A			1.2	V
trr	Reverse Recovery Time	Is=20A ,VDD=50V		82		ns
Qrr	Reverse Recovery Charge	dl/dt=500A/μs , TJ=25℃		180		nc

Notes 1. The maximum current rating is package limited.

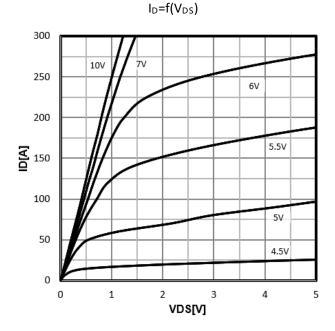
Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 3.EAS condition: TJ=25℃

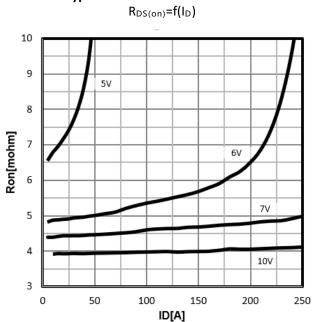


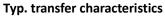
Characteristics Curve:

Typ. output characteristics

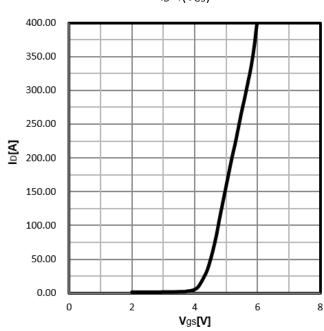


Typ. drain-source on resistance



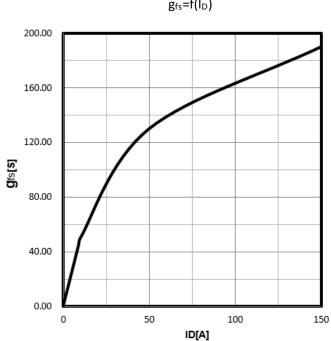


 $I_D = f(V_{GS})$



Typ. forward transconductance

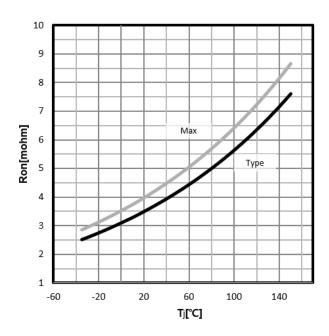
 $g_{fs}=f(I_D)$



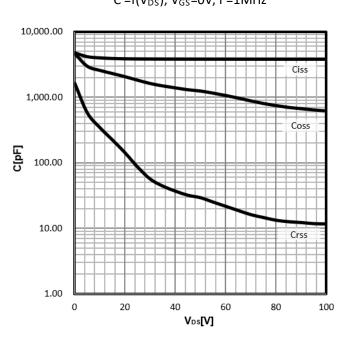


Drain-source on-state resistance

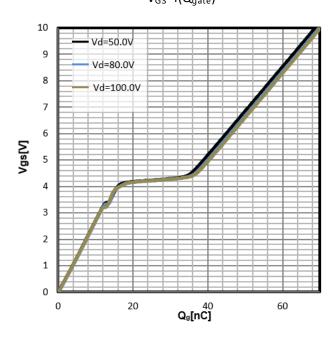
 $R_{DS(on)}$ =f(T $_{j}$); I_{D} =75A; V_{GS} =10V



Typ. capacitances $C = f(V_{DS}); V_{GS} = 0V; f = 1MHz$

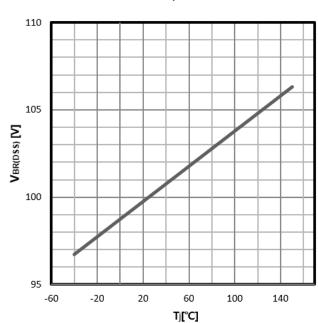


Typ. gate charge V_{GS} = $f(Q_{gate})$

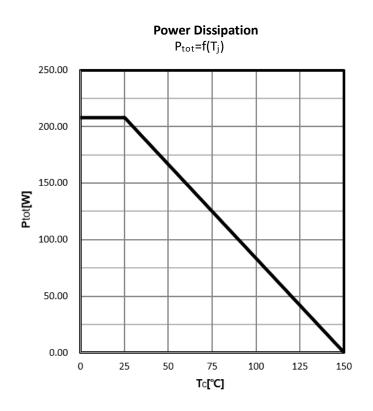


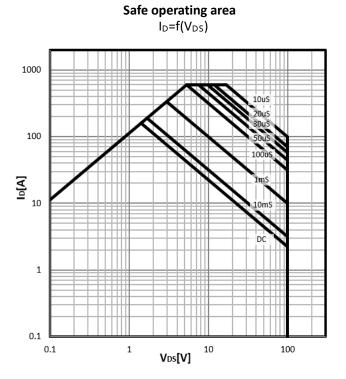
Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_j); I_D=250uA$

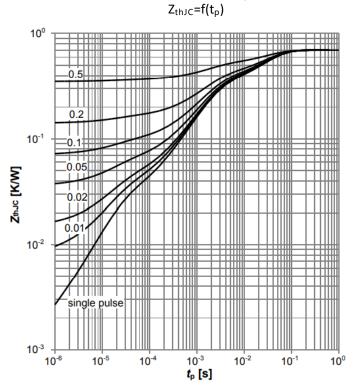






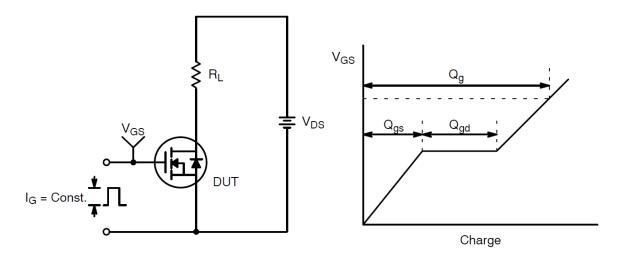


Max. transient thermal impedance

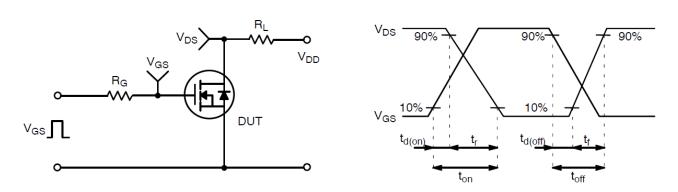




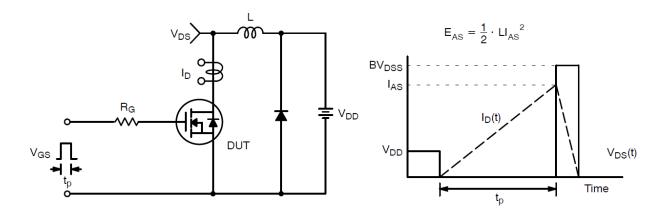
Test Circuit and Waveform:



Gate Charge Test Circuit & Waveform



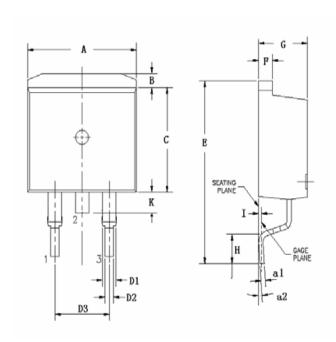
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



TO-263 PACKAGE INFORMATION



Dimentions in mm unless otherwise specified

Symbol	Min	Nom	Max
А	9.66	9.97	10.28
В	1.02	1.17	1.32
С	8.59	9.00	9.40
D1	1.14	1.27	1.40
D2	0.70	0.83	0.95
D3		5.08	
Е	15.09	15.24	15.39
F	1.15	1.28	1.40
G	4.30	4.50	4.70
Н	2.29	2.54	2.79
I		0.25	
K	1.30	1.45	1.60
a1	0.45	0.55	0.65
a2(degree)	0°		8°



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